

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/722,568	BAE, WON-YOUL	
Examiner	Art Unit	
Brian E. Miller	2627	

SEARCHED					
Class	Subclass	Date	Examiner		
720	616,610				
720	627,630				
720	631				
360	99.02		1		
360	99.03	7/21/2006	BEM		
		,			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST Search	6/23/2006	ВЕМ
PLUS Search	7/21/2006	ВЕМ
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